

ATTACHMENT A – HAC TEST PLOTS

Test Laboratory: HCT

DUT: Nokia 6215i; Type: Folder; Serial: #1
Program Name: HAC E Device

Communication System: CDMA 835MHz FCC; Frequency: 824.7 MHz; Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1000$ kg/m³

Phantom section: E Device Section

DASY4 Configuration:

- Probe: ER3DV6 - SN2343; ConvF(1, 1, 1); Calibrated: 2005-04-27

- Sensor-Surface: (Fix Surface)

- Electronics: DAE4 Sn614; Calibrated: 2005-04-21

- Phantom: HAC Test Arch; Type: SD HAC P01 BA

E Scan 10mm above Device Reference/Hearing Aid Compatibility Test (101x101x1):

Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 62.6 V/m

Probe Modulation Factor = 1.00

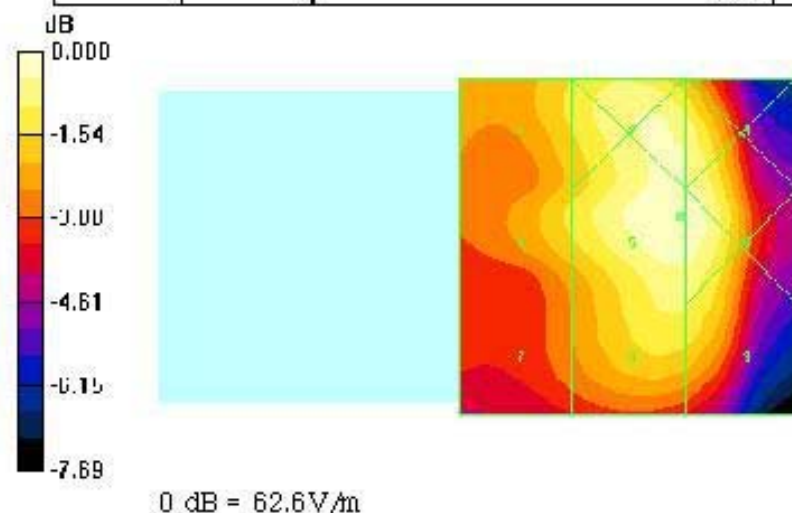
Reference Value = 57.6 V/m; Power Drift = -0.046 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak E-field in V/m

Grid 1	Grid 2	Grid 3
53.3	60.7	60.4
Grid 4	Grid 5	Grid 6
53.2	62.6	62.4
Grid 7	Grid 8	Grid 9
46.9	56.2	56.1

Category	AWF (dB)	Limits for E-Field Emissions (V/m)	Limits for H-Field Emissions (A/m)
M1	0	199.5 - 354.8	0.6 - 1.07
	-5	149.6 - 266.1	0.45 - 0.8
M2	0	112.2 - 199.5	0.34 - 0.6
	-5	84.1 - 149.6	0.25 - 0.45
M3	0	63.1 - 112.2	0.19 - 0.34
	-5	47.3 - 84.1	0.15 - 0.25
M4	0	<63.1	<0.19
	-5	<47.3	<0.15



Test Laboratory: HCT

DUT: Nokia 6215i; Type: Folder; Serial: #1
Program Name: HAC E Device

Communication System: CDMA 835MHz FCC; Frequency: 824.7 MHz; Duty Cycle: 1:1

Medium parameters used: $\sigma = 0 \text{ mho/m}$, $\epsilon_r = 1$; $\rho = 1000 \text{ kg/m}^3$

Phantom section: E Device Section

DASY4 Configuration:

- Probe: ER3DV6 - SN2343; ConvF(1, 1, 1); Calibrated: 2005-04-27

- Sensor-Surface: (Fix Surface)

- Electronics: DAE4 Sn614; Calibrated: 2005-04-21

- Phantom: HAC Test Arch; Type: SD HAC P01 BA

E Scan 10mm above Device Reference/Hearing Aid Compatibility Test (101x101x1):

Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 68.8 V/m

Probe Modulation Factor = 1.00

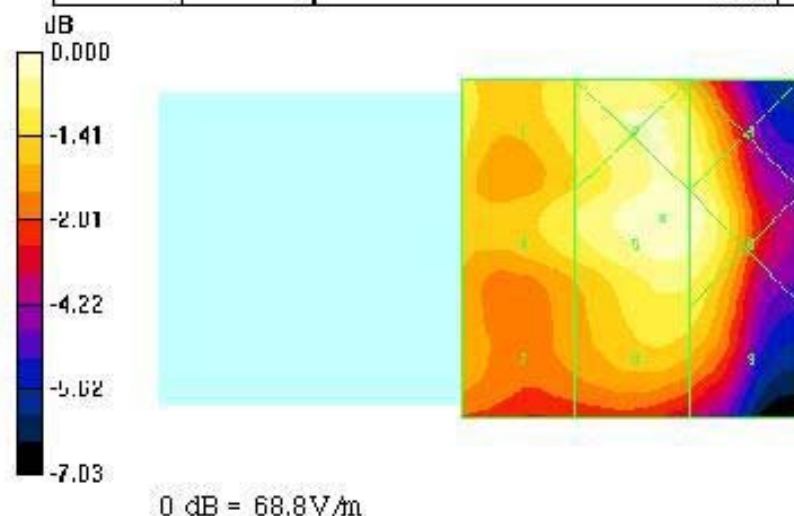
Reference Value = 65.5 V/m; Power Drift = 0.069 dB

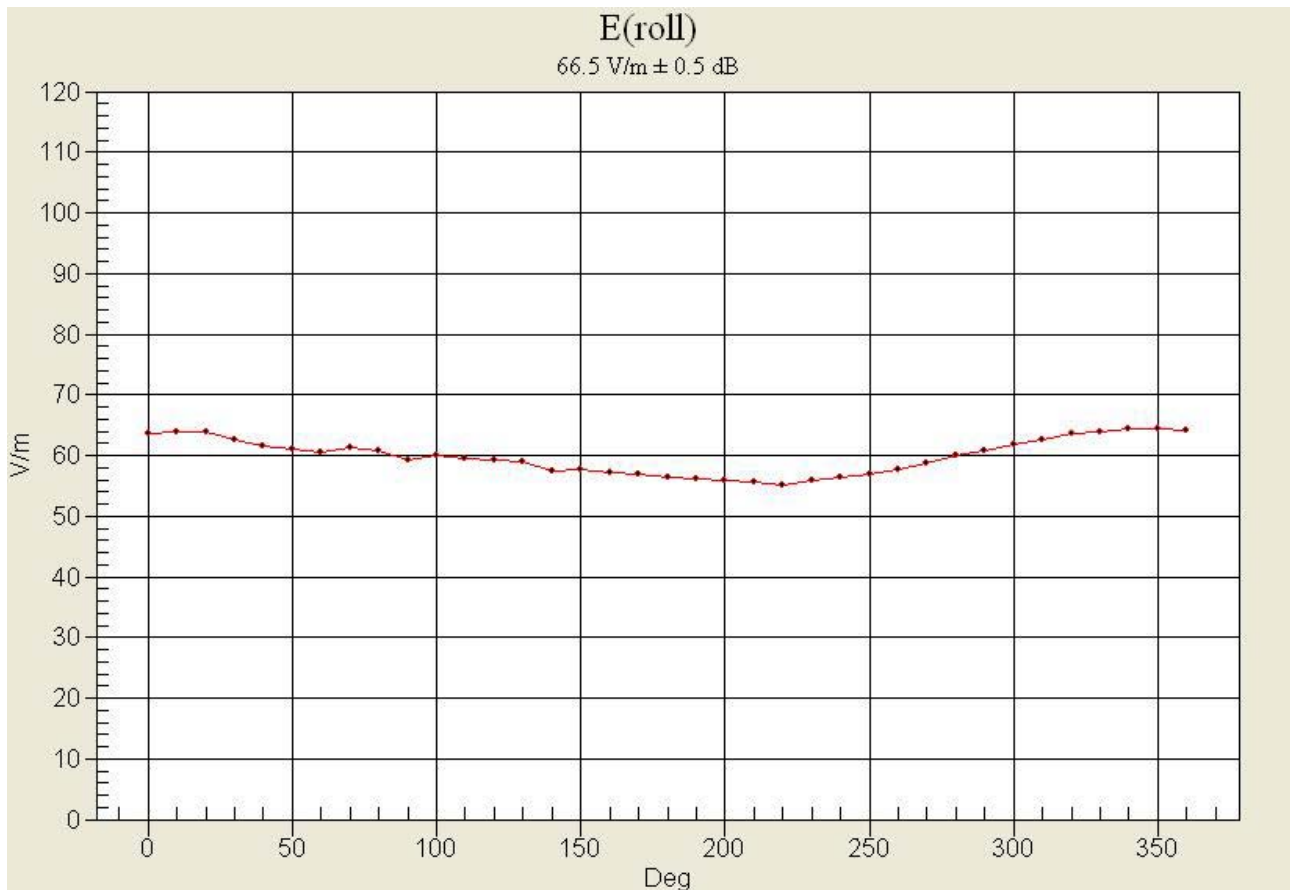
Hearing Aid Hear-Field Category: **M3 (AWF 0 dB)**

Peak E-field in V/m

Grid 1	Grid 2	Grid 3
61.3	66.3	65.5
Grid 4	Grid 5	Grid 6
61.8	68.8	67.9
Grid 7	Grid 8	Grid 9
55.2	61.3	60.5

Category	AWF (dB)	Limits for E-Field Emissions (V/m)	Limits for H-Field Emissions (A/m)
M1	0	199.5 - 354.8	0.6 - 1.07
	-5	149.6 - 266.1	0.45 - 0.8
M2	0	112.2 - 199.5	0.34 - 0.6
	-5	84.1 - 149.6	0.25 - 0.45
M3	0	63.1 - 112.2	0.19 - 0.34
	-5	47.3 - 84.1	0.15 - 0.25
M4	0	<63.1	<0.19
	-5	<47.3	<0.15





Test Laboratory: HCT

DUT: Nokia 6215i; Type: Folder; Serial: #1

Program Name: HAC E Device

Communication System: CDMA 835MHz FCC; Frequency: 836.52 MHz; Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1000$ kg/m³

Phantom section: E Device Section

DASY4 Configuration:

- Probe: ER3DV6 - SN2343; ConvF(1, 1, 1); Calibrated: 2005-04-27

- Sensor-Surface: (Fix Surface)

- Electronics: DAE4 Sn614; Calibrated: 2005-04-21

- Phantom: HAC Test Arch; Type: SD HAC P01 BA

E Scan 10mm above Device Reference/Hearing Aid Compatibility Test (101x101x1):

Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 58.5 V/m

Probe Modulation Factor = 1.00

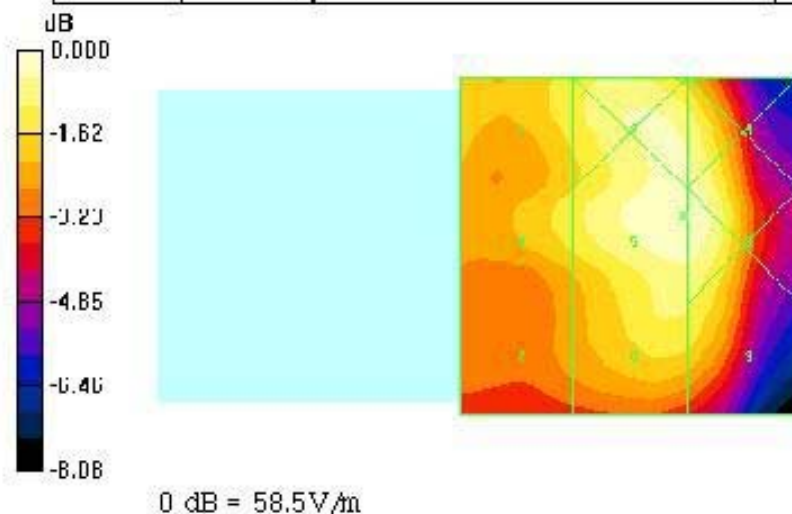
Reference Value = 54.9 V/m; Power Drift = -0.036 dB

Hearing Aid Hear-Field Category: **M4 (AWF 0 dB)**

Peak E-field in V/m

Grid 1	Grid 2	Grid 3
50.7	56.7	56.6
Grid 4	Grid 5	Grid 6
50.6	58.5	58.4
Grid 7	Grid 8	Grid 9
44.4	52.4	52.1

Category	AWF (dB)	Limits for E-Field Emissions (V/m)	Limits for H-Field Emissions (A/m)
M1	0	199.5 - 354.8	0.6 - 1.07
	-5	149.6 - 266.1	0.45 - 0.8
M2	0	112.2 - 199.5	0.34 - 0.6
	-5	84.1 - 149.6	0.25 - 0.45
M3	0	63.1 - 112.2	0.19 - 0.34
	-5	47.3 - 84.1	0.15 - 0.25
M4	0	<63.1	<0.19
	-5	<47.3	<0.15



Test Laboratory: HCT

DUT: Nokia 6215i; Type: Folder; Serial: #1
Program Name: HAC E Device

Communication System: CDMA 835MHz FCC; Frequency: 836.52 MHz; Duty Cycle: 1:1

Medium parameters used: $\sigma = 0 \text{ mho/m}$, $\epsilon_r = 1$; $\rho = 1000 \text{ kg/m}^3$

Phantom section: E Device Section

DASY4 Configuration:

- Probe: ER3DV6 - SN2343; ConvF(1, 1, 1); Calibrated: 2005-04-27

- Sensor-Surface: (Fix Surface)

- Electronics: DAE4 Sn614; Calibrated: 2005-04-21

- Phantom: HAC Test Arch; Type: SD HAC P01 BA

E Scan 10mm above Device Reference/Hearing Aid Compatibility Test (101x101x1):

Measurement grid: $dx=5\text{mm}$, $dy=5\text{mm}$

Maximum value of peak Total field = 66.1 V/m

Probe Modulation Factor = 1.00

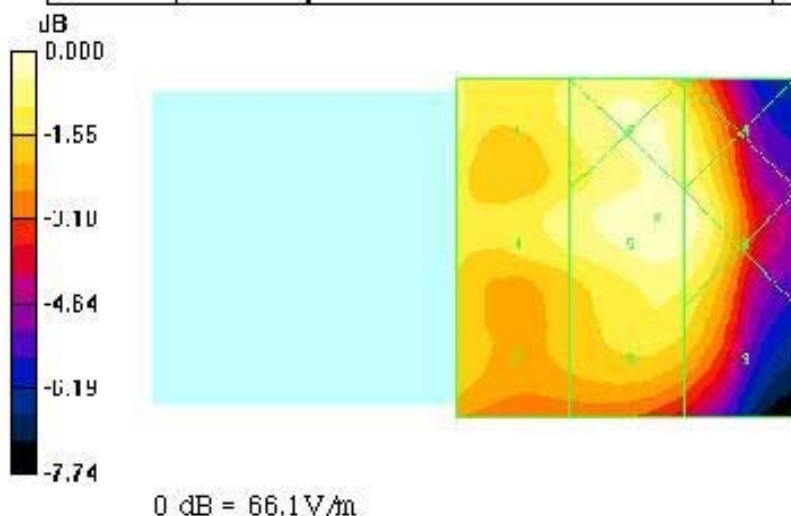
Reference Value = 68.4 V/m; Power Drift = 0.005 dB

Hearing Aid Hear-Field Category: **M3 (AWF 0 dB)**

Peak E-field in V/m

Grid 1	Grid 2	Grid 3
60.4	63.7	62.6
Grid 4	Grid 5	Grid 6
60.6	66.1	64.8
Grid 7	Grid 8	Grid 9
55.6	58.8	57.5

Category	AWF (dB)	Limits for E-Field Emissions (V/m)	Limits for H-Field Emissions (A/m)
M1	0	199.5 - 354.8	0.6 - 1.07
	-5	149.6 - 266.1	0.45 - 0.8
M2	0	112.2 - 199.5	0.34 - 0.6
	-5	84.1 - 149.6	0.25 - 0.45
M3	0	63.1 - 112.2	0.19 - 0.34
	-5	47.3 - 84.1	0.15 - 0.25
M4	0	<63.1	<0.19
	-5	<47.3	<0.15



Test Laboratory: HCT

DUT: Nokia 6215i; Type: Folder; Serial: #1
Program Name: HAC E Device

Communication System: CDMA 835MHz FCC; Frequency: 848.31 MHz; Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1000$ kg/m³

Phantom section: E Device Section

DASY4 Configuration:

- Probe: ER3DV6 - SN2343; ConvF(1, 1, 1); Calibrated: 2005-04-27

- Sensor-Surface: (Fix Surface)

- Electronics: DAE4 Sn614; Calibrated: 2005-04-21

- Phantom: HAC Test Arch; Type: SD HAC P01 BA

E Scan 10mm above Device Reference/Hearing Aid Compatibility Test (101x101x1):

Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 49.0 V/m

Probe Modulation Factor = 1.00

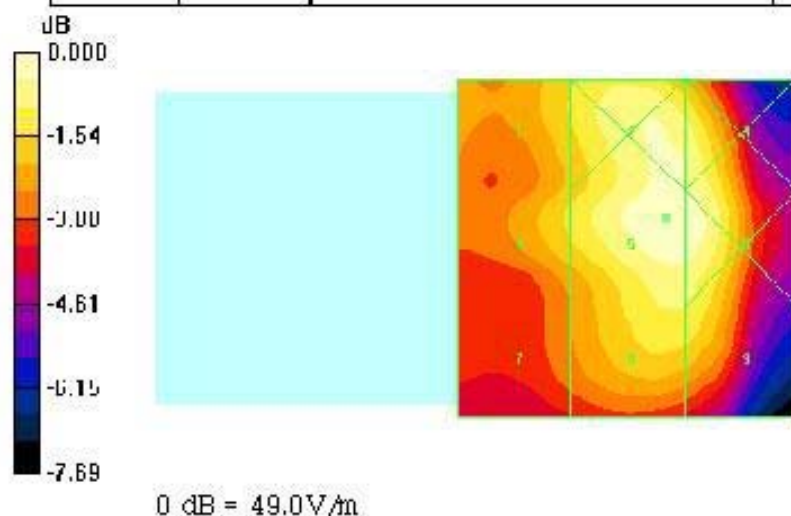
Reference Value = 45.8 V/m; Power Drift = 0.088 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak E-field in V/m

Grid 1	Grid 2	Grid 3
41.3	47.4	47.1
Grid 4	Grid 5	Grid 6
41.6	49.0	48.7
Grid 7	Grid 8	Grid 9
36.6	43.7	43.6

Category	AWF (dB)	Limits for E-Field Emissions (V/m)	Limits for H-Field Emissions (A/m)
M1	0	199.5 - 354.8	0.6 - 1.07
	-5	149.6 - 266.1	0.45 - 0.8
M2	0	112.2 - 199.5	0.34 - 0.6
	-5	84.1 - 149.6	0.25 - 0.45
M3	0	63.1 - 112.2	0.19 - 0.34
	-5	47.3 - 84.1	0.15 - 0.25
M4	0	<63.1	<0.19
	-5	<47.3	<0.15



Test Laboratory: HCT

DUT: Nokia 6215i; Type: Folder; Serial: #1
Program Name: HAC E Device

Communication System: CDMA 835MHz FCC; Frequency: 848.31 MHz; Duty Cycle: 1:1

Medium parameters used: $\sigma = 0 \text{ rho/m}$, $\epsilon_r = 1$; $\rho = 1000 \text{ kg/m}^3$

Phantom section: E Device Section

DASY4 Configuration:

- Probe: ER3DV6 - SN2343; ConvF(1, 1, 1); Calibrated: 2005-04-27

- Sensor-Surface: (Fix Surface)

- Electronics: DAE4 Sn614; Calibrated: 2005-04-21

- Phantom: HAC Test Arch; Type: SD HAC P01 BA

E Scan 10mm above Device Reference/Hearing Aid Compatibility Test (101x101x1):

Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 57.3 V/m

Probe Modulation Factor = 1.00

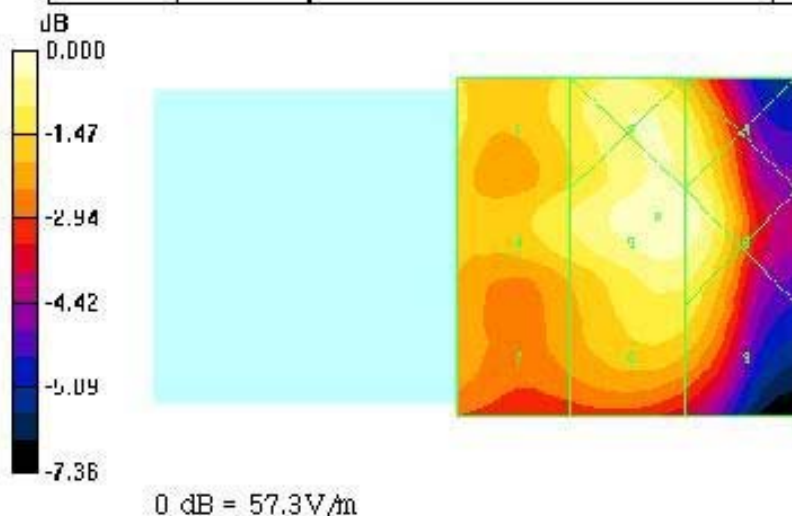
Reference Value = 55.0 V/m; Power Drift = -0.152 dB

Hearing Aid Hear-Field Category: **M4 (AWF 0 dB)**

Peak E-field in V/m

Grid 1	Grid 2	Grid 3
50.0	55.2	54.6
Grid 4	Grid 5	Grid 6
51.2	57.3	56.5
Grid 7	Grid 8	Grid 9
45.7	50.9	50.1

Category	AWF (dB)	Limits for E-Field Emissions (V/m)	Limits for H-Field Emissions (A/m)
M1	0	199.5 - 354.8	0.6 - 1.07
	-5	149.6 - 266.1	0.45 - 0.8
M2	0	112.2 - 199.5	0.34 - 0.6
	-5	84.1 - 149.6	0.25 - 0.45
M3	0	63.1 - 112.2	0.19 - 0.34
	-5	47.3 - 84.1	0.15 - 0.25
M4	0	<63.1	<0.19
	-5	<47.3	<0.15



Test Laboratory: HCT

DUT: Nokia 6215i; Type: Folder; Serial: #1

Program Name: HAC E Device

Communication System: PCS1900; Frequency: 1851.25 MHz; Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1000$ kg/m³

Phantom section: E Device Section

DASY4 Configuration:

- Probe: ER3DV6 - SN2343; ConvF(1, 1, 1); Calibrated: 2005-04-27

- Sensor-Surface: (Fix Surface)

- Electronics: DAE4 Sn614; Calibrated: 2005-04-21

- Phantom: HAC Test Arch; Type: SD HAC P01 BA

E Scan 10mm above Device Reference/Hearing Aid Compatibility Test (101x101x1):

Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 25.6 V/m

Probe Modulation Factor = 0.980

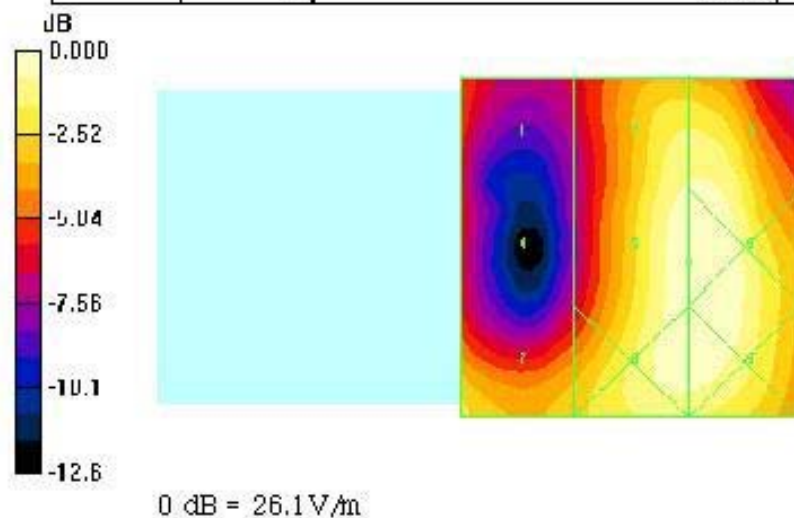
Reference Value = 18.4 V/m; Power Drift = -0.128 dB

Hearing Aid Hear-Field Category: M4 (AWF 0 dB)

Peak E-field in V/m

Grid 1	Grid 2	Grid 3
14.9	24.1	24.2
Grid 4	Grid 5	Grid 6
13.3	25.6	26.1
Grid 7	Grid 8	Grid 9
20.3	25.6	25.9

Category	AWF (dB)	Limits for E-Field Emissions (V/m)	Limits for H-Field Emissions (A/m)
M1	0	199.5 - 354.8	0.6 - 1.07
	-5	149.6 - 266.1	0.45 - 0.8
M2	0	112.2 - 199.5	0.34 - 0.6
	-5	84.1 - 149.6	0.25 - 0.45
M3	0	63.1 - 112.2	0.19 - 0.34
	-5	47.3 - 84.1	0.15 - 0.25
M4	0	<63.1	<0.19
	-5	<47.3	<0.15



Test Laboratory: HCT

DUT: Nokia 6215i; Type: Folder; Serial: #1
Program Name: HAC E Device

Communication System: PCS1900; Frequency: 1851.25 MHz; Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1000$ kg/m³

Phantom section: E Device Section

DASY4 Configuration:

- Probe: ER3DV6 - SN2343; ConvF(1, 1, 1); Calibrated: 2005-04-27

- Sensor-Surface: (Fix Surface)

- Electronics: DAE4 Sn614; Calibrated: 2005-04-21

- Phantom: HAC Test Arch; Type: SD HAC P01 BA

E Scan 10mm above Device Reference/Hearing Aid Compatibility Test (101x101x1):

Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 58.8 V/m

Probe Modulation Factor = 0.980

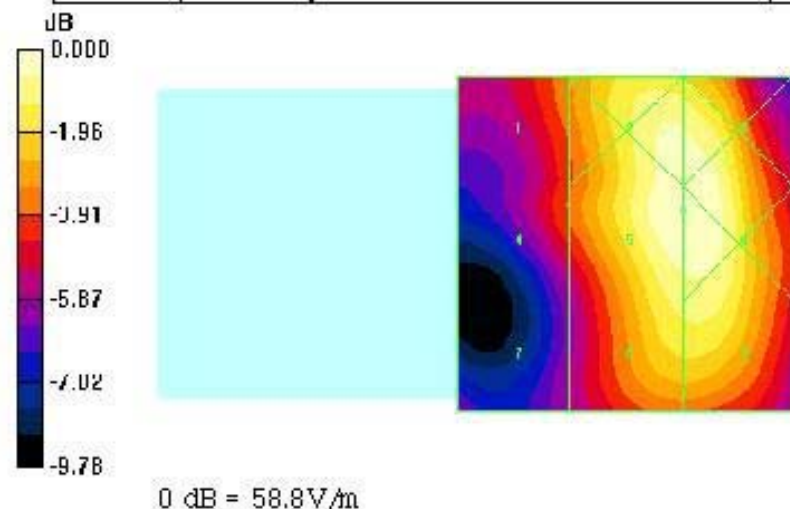
Reference Value = 48.1 V/m; Power Drift = 0.051 dB

Hearing Aid Hear-Field Category: **M4 (AWF 0 dB)**

Peak E-field in V/m

Grid 1	Grid 2	Grid 3
40.0	57.9	57.9
Grid 4	Grid 5	Grid 6
38.0	58.8	58.8
Grid 7	Grid 8	Grid 9
30.0	52.2	52.6

Category	AWF (dB)	Limits for E-Field Emissions (V/m)	Limits for H-Field Emissions (A/m)
M1	0	199.5 - 354.8	0.6 - 1.07
	-5	149.6 - 266.1	0.45 - 0.8
M2	0	112.2 - 199.5	0.34 - 0.6
	-5	84.1 - 149.6	0.25 - 0.45
M3	0	63.1 - 112.2	0.19 - 0.34
	-5	47.3 - 84.1	0.15 - 0.25
M4	0	<63.1	<0.19
	-5	<47.3	<0.15



Test Laboratory: HCT

DUT: Nokia 6215i; Type: Folder; Serial: #1
Program Name: HAC E Device

Communication System: PCS1900; Frequency: 1880 MHz; Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1000$ kg/m³

Phantom section: E Device Section

DASY4 Configuration:

- Probe: ER3DV6 - SN2343; ConvF(1, 1, 1); Calibrated: 2005-04-27

- Sensor-Surface: (Fix Surface)

- Electronics: DAE4 Sn614; Calibrated: 2005-04-21

- Phantom: HAC Test Arch; Type: SD HAC P01 BA

E Scan 10mm above Device Reference/Hearing Aid Compatibility Test (101x101x1):

Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 23.0 V/m

Probe Modulation Factor = 0.980

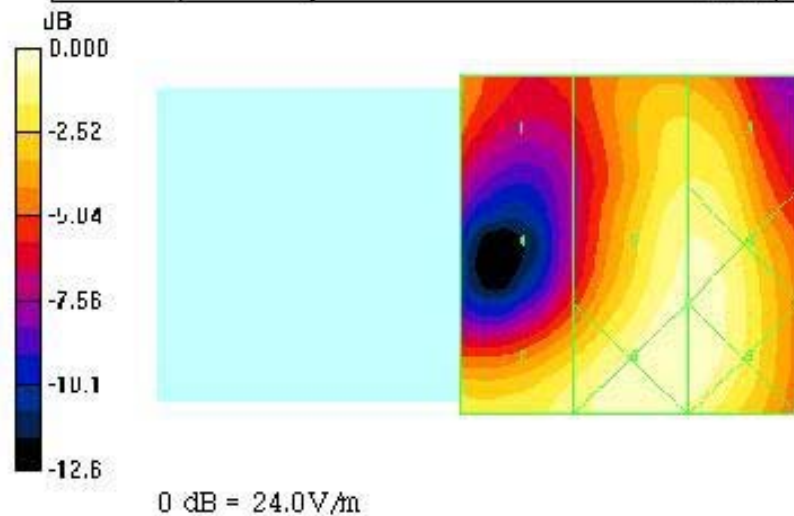
Reference Value = 16.0 V/m; Power Drift = -0.146 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak E-field in V/m

Grid 1	Grid 2	Grid 3
15.1	20.1	20.1
Grid 4	Grid 5	Grid 6
12.7	23.0	23.0
Grid 7	Grid 8	Grid 9
20.8	24.0	23.7

Category	AWF (dB)	Limits for E-Field Emissions (V/m)	Limits for H-Field Emissions (A/m)
M1	0	199.5 - 354.8	0.6 - 1.07
	-5	149.6 - 266.1	0.45 - 0.8
M2	0	112.2 - 199.5	0.34 - 0.6
	-5	84.1 - 149.6	0.25 - 0.45
M3	0	63.1 - 112.2	0.19 - 0.34
	-5	47.3 - 84.1	0.15 - 0.25
M4	0	<63.1	<0.19
	-5	<47.3	<0.15



Test Laboratory: HCT

DUT: Nokia 6215i; Type: Folder; Serial: #1
Program Name: HAC E Device

Communication System: PCS1900; Frequency: 1880 MHz; Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1000$ kg/m³

Phantom section: E Device Section

DASY4 Configuration:

- Probe: ER3DV6 - SN2343; ConvF(1, 1, 1); Calibrated: 2005-04-27

- Sensor-Surface: (Fix Surface)

- Electronics: DAE4 Sn614; Calibrated: 2005-04-21

- Phantom: HAC Test Arch; Type: SD HAC P01 BA

E Scan 10mm above Device Reference/Hearing Aid Compatibility Test (101x101x1):

Measurement grid: $d_x=5$ mm, $d_y=5$ mm

Maximum value of peak Total field = 51.4 V/m

Probe Modulation Factor = 0.980

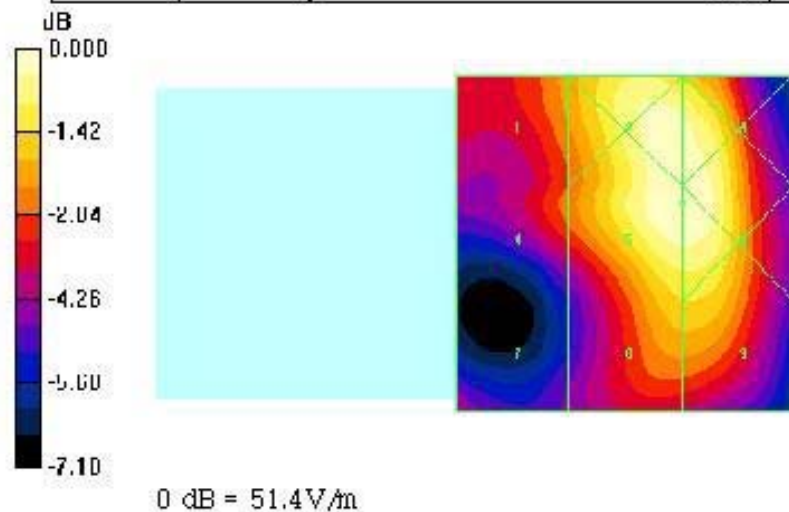
Reference Value = 44.8 V/m; Power Drift = -0.008 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak E-field in V/m

Grid 1	Grid 2	Grid 3
40.1	50.9	50.9
Grid 4	Grid 5	Grid 6
38.2	51.4	51.4
Grid 7	Grid 8	Grid 9
31.9	43.5	43.7

Category	AWF (dB)	Limits for E-Field Emissions (V/m)	Limits for H-Field Emissions (A/m)
M1	0	199.5 - 354.8	0.6 - 1.07
	-5	149.6 - 266.1	0.45 - 0.8
M2	0	112.2 - 199.5	0.34 - 0.6
	-5	84.1 - 149.6	0.25 - 0.45
M3	0	63.1 - 112.2	0.19 - 0.34
	-5	47.3 - 84.1	0.15 - 0.25
M4	0	<63.1	<0.19
	-5	<47.3	<0.15



Test Laboratory: HCT

DUT: Nokia 6215i; Type: Folder; Serial: #1
Program Name: HAC E Device

Communication System: PCS1900; Frequency: 1908.75 MHz; Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1000$ kg/m³

Phantom section: E Device Section

DASY4 Configuration:

- Probe: ER3DV6 - SN2343; ConvF(1, 1, 1); Calibrated: 2005-04-27

- Sensor-Surface: (Fix Surface)

- Electronics: DAE4 Sn614; Calibrated: 2005-04-21

- Phantom: HAC Test Arch; Type: SD HAC P01 BA

E Scan 10mm above Device Reference/Hearing Aid Compatibility Test (101x101x1):

Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 20.8 V/m

Probe Modulation Factor = 0.980

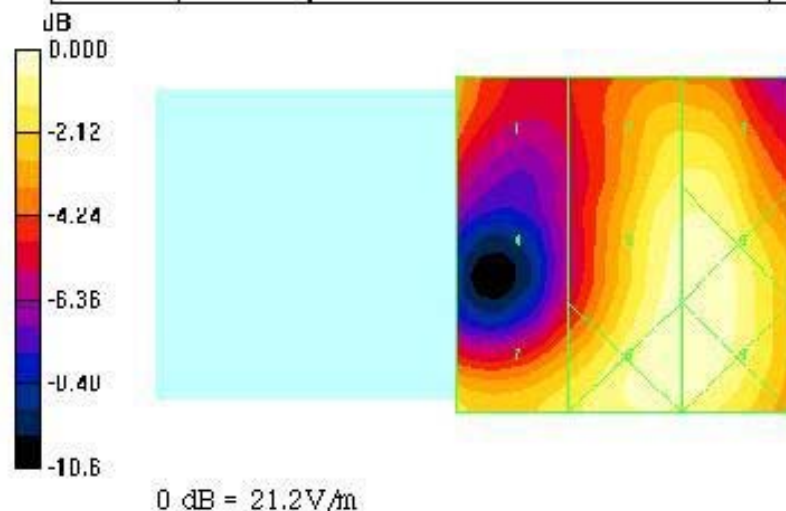
Reference Value = 15.0 V/m; Power Drift = 0.049 dB

Hearing Aid Hear-Field Category: **M4 (AWF 0 dB)**

Peak E-field in V/m

Grid 1	Grid 2	Grid 3
14.7	18.6	18.7
Grid 4	Grid 5	Grid 6
11.3	20.8	21.0
Grid 7	Grid 8	Grid 9
17.5	21.1	21.2

Category	AWF (dB)	Limits for E-Field Emissions (V/m)	Limits for H-Field Emissions (A/m)
M1	0	199.5 - 354.8	0.6 - 1.07
	-5	149.6 - 266.1	0.45 - 0.8
M2	0	112.2 - 199.5	0.34 - 0.6
	-5	84.1 - 149.6	0.25 - 0.45
M3	0	63.1 - 112.2	0.19 - 0.34
	-5	47.3 - 84.1	0.15 - 0.25
M4	0	<63.1	<0.19
	-5	<47.3	<0.15



Test Laboratory: HCT

DUT: Nokia 6215i; Type: Folder; Serial: #1
Program Name: HAC E Device

Communication System: PCS1900; Frequency: 1908.75 MHz; Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1000$ kg/m³

Phantom section: E Device Section

DASY4 Configuration:

- Probe: ER3DV6 - SN2343; ConvF(1, 1, 1); Calibrated: 2005-04-27

- Sensor-Surface: (Fix Surface)

- Electronics: DAE4 Sn614; Calibrated: 2005-04-21

- Phantom: HAC Test Arch; Type: SD HAC P01 BA

E Scan 10mm above Device Reference/Hearing Aid Compatibility Test (101x101x1):

Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 48.9 V/m

Probe Modulation Factor = 0.980

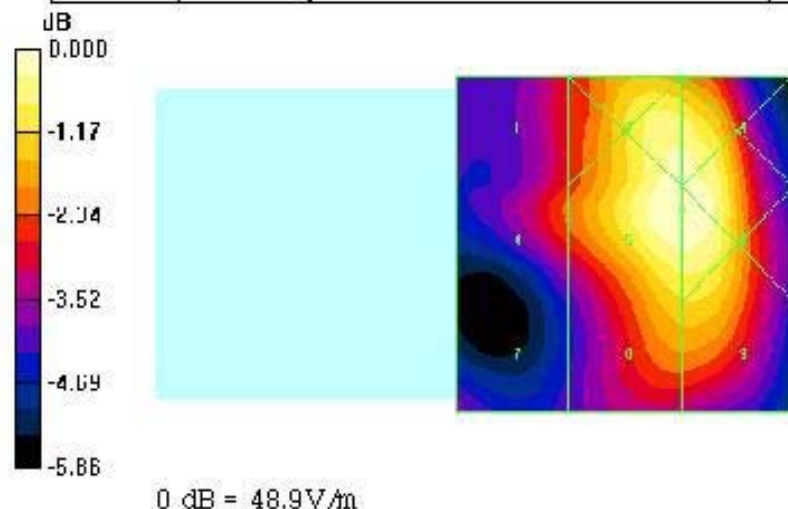
Reference Value = 42.8 V/m; Power Drift = -0.065 dB

Hearing Aid Hear-Field Category: **M4 (AWF 0 dB)**

Peak E-field in V/m

Grid 1	Grid 2	Grid 3
36.3	48.1	48.1
Grid 4	Grid 5	Grid 6
37.9	48.9	48.9
Grid 7	Grid 8	Grid 9
32.6	42.5	42.7

Category	AWF (dB)	Limits for E-Field Emissions (V/m)	Limits for H-Field Emissions (A/m)
M1	0	199.5 - 354.8	0.6 - 1.07
	-5	149.6 - 266.1	0.45 - 0.8
M2	0	112.2 - 199.5	0.34 - 0.6
	-5	84.1 - 149.6	0.25 - 0.45
M3	0	63.1 - 112.2	0.19 - 0.34
	-5	47.3 - 84.1	0.15 - 0.25
M4	0	<63.1	<0.19
	-5	<47.3	<0.15



Test Laboratory: HCT

DUT: Nokia 6215i; Type: Folder; Serial: #1
Program Name: HAC H Device

Communication System: CDMA 835MHz FCC; Frequency: 824.7 MHz; Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³

Phantom section: H Device Section

DASY4 Configuration:

- Probe: H3DV6 - SN6101;; Calibrated: 2005-07-20

- Sensor-Surface: (Fix Surface)

- Electronics: DAE4 Sn614; Calibrated: 2005-04-21

- Phantom: HAC Test Arch; Type: SD HAC P01 BA

H Scan 10mm above Device Reference/Hearing Aid Compatibility Test (101x101x1):

Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.082 A/m

Probe Modulation Factor = 1.00

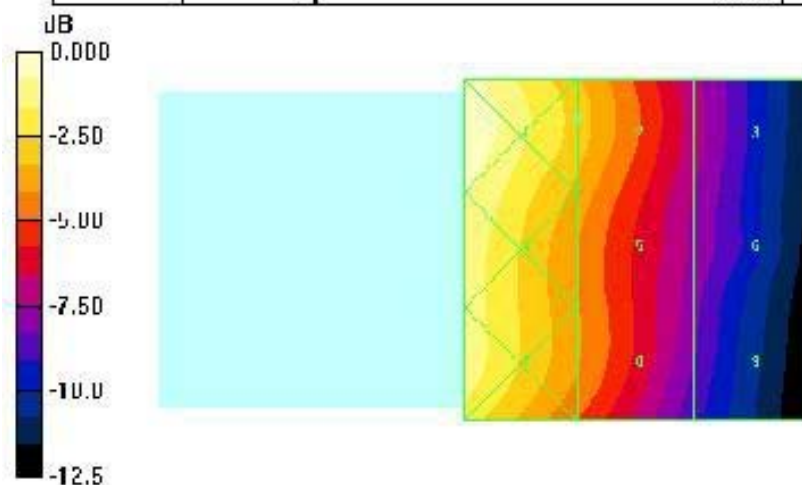
Reference Value = 0.068 A/m; Power Drift = -0.044 dB

Hearing Aid Hear-Field Category: M4 (AWF 0 dB)

Peak H-field in A/m

Grid 1	Grid 2	Grid 3
0.128	0.092	0.057
Grid 4	Grid 5	Grid 6
0.118	0.085	0.054
Grid 7	Grid 8	Grid 9
0.113	0.081	0.051

Category	AWF (dB)	Limits for E-Field Emissions (V/m)	Limits for H-Field Emissions (A/m)
M1	0	199.5 - 354.8	0.6 - 1.07
	-5	149.6 - 266.1	0.45 - 0.8
M2	0	112.2 - 199.5	0.34 - 0.6
	-5	84.1 - 149.6	0.25 - 0.45
M3	0	63.1 - 112.2	0.19 - 0.34
	-5	47.3 - 84.1	0.15 - 0.25
M4	0	<63.1	<0.19
	-5	<47.3	<0.15



Test Laboratory: HCT

DUT: Nokia 6215i; Type: Folder; Serial: #1

Program Name: HAC H Device

Communication System: CDMA 835MHz FCC; Frequency: 824.7 MHz; Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³

Phantom section: H Device Section

DASY4 Configuration:

- Probe: H3DV6 - SN6101; ; Calibrated: 2005-07-20

- Sensor-Surface: (Fix Surface)

- Electronics: DAE4 Sn614; Calibrated: 2005-04-21

- Phantom: HAC Test Arch; Type: SD HAC P01 BA

H Scan 10mm above Device Reference/Hearing Aid Compatibility Test (101x101x1):

Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.112 A/m

Probe Modulation Factor = 1.00

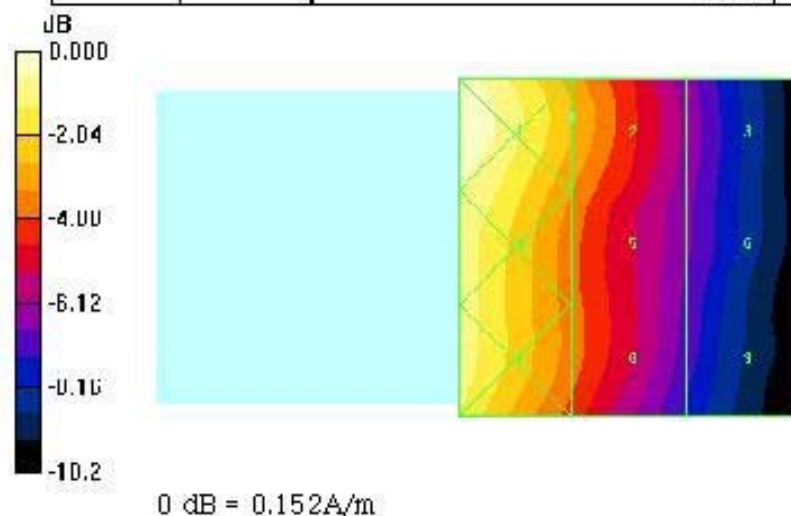
Reference Value = 0.078 A/m; Power Drift = 0.118 dB

Hearing Aid Hear-Field Category: M4 (AWF 0 dB)

Peak H-field in A/m

Grid 1	Grid 2	Grid 3
0.152	0.112	0.074
Grid 4	Grid 5	Grid 6
0.141	0.104	0.072
Grid 7	Grid 8	Grid 9
0.137	0.100	0.068

Category	AWF (dB)	Limits for E-Field Emissions (V/m)	Limits for H-Field Emissions (A/m)
M1	0	199.5 - 354.8	0.6 - 1.07
	-5	149.6 - 266.1	0.45 - 0.8
M2	0	112.2 - 199.5	0.34 - 0.6
	-5	84.1 - 149.6	0.25 - 0.45
M3	0	63.1 - 112.2	0.19 - 0.34
	-5	47.3 - 84.1	0.15 - 0.25
M4	0	<63.1	<0.19
	-5	<47.3	<0.15



Test Laboratory: HCT

DUT: Nokia 6215i; Type: Folder; Serial: #1
Program Name: HAC H Device

Communication System: CDMA 835MHz FCC; Frequency: 836.52 MHz; Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³

Phantom section: H Device Section

DASY4 Configuration:

- Probe: H3DV6 - SN6101; ; Calibrated: 2005-07-20

- Sensor-Surface: (Fix Surface)

- Electronics: DAE4 Sn614; Calibrated: 2005-04-21

- Phantom: HAC Test Arch; Type: SD HAC P01 BA

H Scan 10mm above Device Reference/Hearing Aid Compatibility Test (101x101x1):

Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.088 A/m

Probe Modulation Factor = 1.00

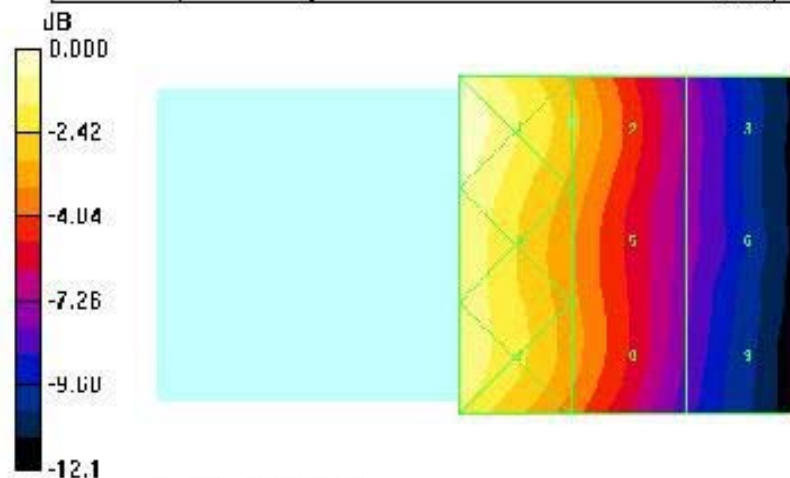
Reference Value = 0.068 A/m; Power Drift = -0.188 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak H-field in A/m

Grid 1	Grid 2	Grid 3
0.123	0.088	0.052
Grid 4	Grid 5	Grid 6
0.115	0.082	0.051
Grid 7	Grid 8	Grid 9
0.112	0.081	0.050

Category	AWF (dB)	Limits for E-Field Emissions (V/m)	Limits for H-Field Emissions (A/m)
M1	0	199.5 - 354.8	0.6 - 1.07
	-5	149.6 - 266.1	0.45 - 0.8
M2	0	112.2 - 199.5	0.34 - 0.6
	-5	84.1 - 149.6	0.25 - 0.45
M3	0	63.1 - 112.2	0.19 - 0.34
	-5	47.3 - 84.1	0.15 - 0.25
M4	0	<63.1	<0.19
	-5	<47.3	<0.15



0 dB = 0.123 A/m

Test Laboratory: HCT

DUT: Nokia 6215i; Type: Folder; Serial: #1
Program Name: HAC H Device

Communication System: CDMA 835MHz FCC; Frequency: 836.52 MHz; Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³

Phantom section: H Device Section

DASY4 Configuration:

- Probe: H3DV6 - SN6101; ; Calibrated: 2005-07-20

- Sensor-Surface: (Fix Surface)

- Electronics: DAE4 Sn614; Calibrated: 2005-04-21

- Phantom: HAC Test Arch; Type: SD HAC P01 BA

H Scan 10mm above Device Reference/Hearing Aid Compatibility Test (101x101x1):

Measurement grid: dx=5mm dy=5mm

Maximum value of peak Total field = 0.106 A/m

Probe Modulation Factor = 1.00

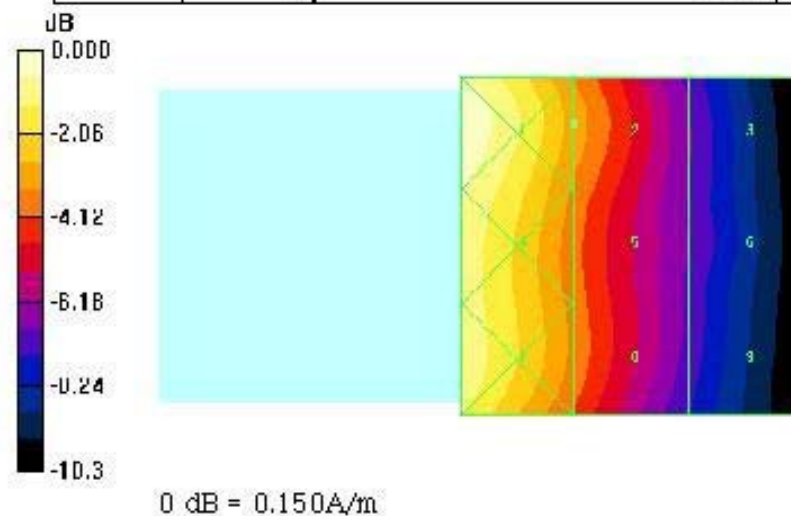
Reference Value = 0.080 A/m; Power Drift = -0.087 dB

Hearing Aid Hear-Field Category: M4 (AWF 0 dB)

Peak H-field in A/m

Grid 1	Grid 2	Grid 3
0.150	0.106	0.069
Grid 4	Grid 5	Grid 6
0.141	0.100	0.068
Grid 7	Grid 8	Grid 9
0.138	0.099	0.067

Category	AWF (dB)	Limits for E-Field Emissions (V/m)	Limits for H-Field Emissions (A/m)
M1	0	199.5 - 354.8	0.6 - 1.07
	-5	149.6 - 266.1	0.45 - 0.8
M2	0	112.2 - 199.5	0.34 - 0.6
	-5	84.1 - 149.6	0.25 - 0.45
M3	0	63.1 - 112.2	0.19 - 0.34
	-5	47.3 - 84.1	0.15 - 0.25
M4	0	<63.1	<0.19
	-5	<47.3	<0.15



Test Laboratory: HCT

DUT: Nokia 6215i; Type: Folder; Serial: #1
Program Name: HAC H Device

Communication System: CDMA 835MHz FCC; Frequency: 848.31 MHz; Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³

Phantom section: H Device Section

DASY4 Configuration:

- Probe: H3DV6 - SN6101;; Calibrated: 2005-07-20

- Sensor-Surface: (Fix Surface)

- Electronics: DAE4 Sn614; Calibrated: 2005-04-21

- Phantom: HAC Test Arch; Type: SD HAC P01 BA

H Scan 10mm above Device Reference/Hearing Aid Compatibility Test (101x101x1):

Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.082 A/m

Probe Modulation Factor = 1.00

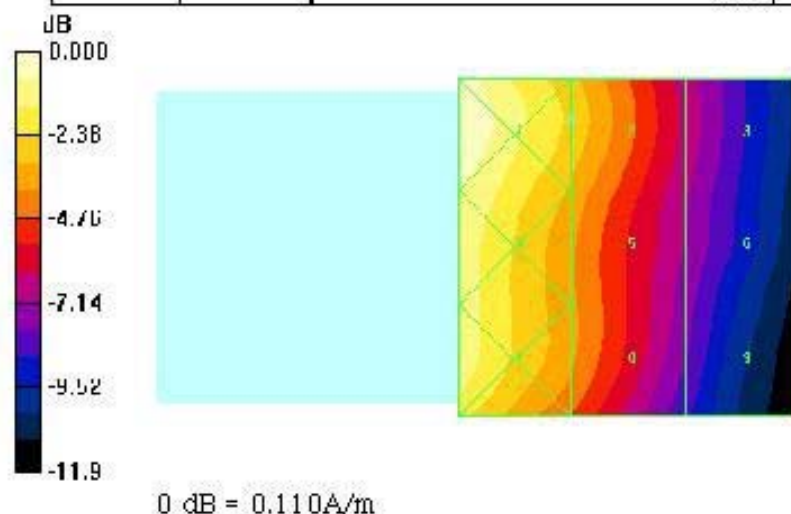
Reference Value = 0.050 A/m; Power Drift = 0.073 dB

Hearing Aid Hear-Field Category: M4 (AWF 0 dB)

Peak H-field in A/m

Grid 1	Grid 2	Grid 3
0.110	0.082	0.051
Grid 4	Grid 5	Grid 6
0.102	0.075	0.049
Grid 7	Grid 8	Grid 9
0.097	0.072	0.046

Category	AWF (dB)	Limits for E-Field Emissions (V/m)	Limits for H-Field Emissions (A/m)
M1	0	199.5 - 354.8	0.6 - 1.07
	-5	149.6 - 266.1	0.45 - 0.8
M2	0	112.2 - 199.5	0.34 - 0.6
	-5	84.1 - 149.6	0.25 - 0.45
M3	0	63.1 - 112.2	0.19 - 0.34
	-5	47.3 - 84.1	0.15 - 0.25
M4	0	<63.1	<0.19
	-5	<47.3	<0.15



Test Laboratory: HCT

DUT: Nokia 6215i; Type: Folder; Serial: #1
Program Name: HAC H Device

Communication System: CDMA 835MHz FCC; Frequency: 848.31 MHz; Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³

Phantom section: H Device Section

DASY4 Configuration:

- Probe: H3DV6 - SN6101; ; Calibrated: 2005-07-20

- Sensor-Surface: (Fix Surface)

- Electronics: DAE4 Sn614; Calibrated: 2005-04-21

- Phantom: HAC Test Arch; Type: SD HAC P01 BA

H Scan 10mm above Device Reference/Hearing Aid Compatibility Test (101x101x1):

Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.114 A/m

Probe Modulation Factor = 1.00

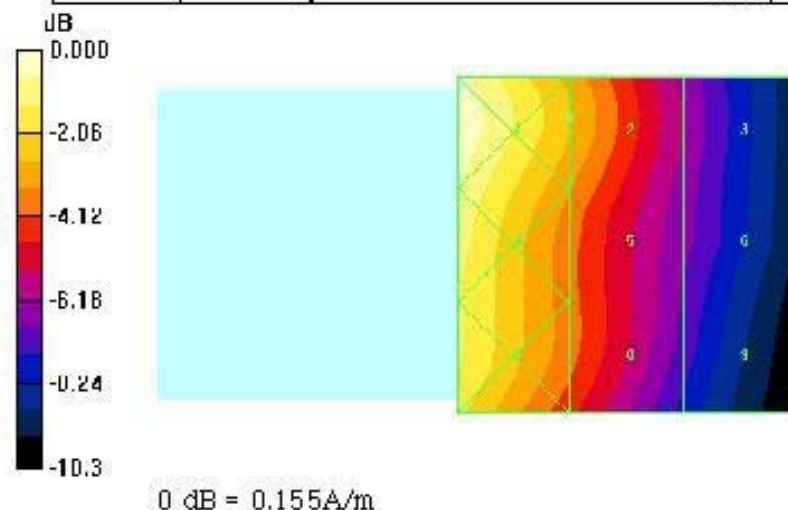
Reference Value = 0.088 A/m; Power Drift = -0.108 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak H-field in A/m

Grid 1	Grid 2	Grid 3
0.155	0.114	0.076
Grid 4	Grid 5	Grid 6
0.144	0.105	0.074
Grid 7	Grid 8	Grid 9
0.134	0.100	0.070

Category	AWF (dB)	Limits for E-Field Emissions (V/m)	Limits for H-Field Emissions (A/m)
M1	0	199.5 - 354.8	0.6 - 1.07
	-5	149.6 - 266.1	0.45 - 0.8
M2	0	112.2 - 199.5	0.34 - 0.6
	-5	84.1 - 149.6	0.25 - 0.45
M3	0	63.1 - 112.2	0.19 - 0.34
	-5	47.3 - 84.1	0.15 - 0.25
M4	0	<63.1	<0.19
	-5	<47.3	<0.15



Test Laboratory: HCT

DUT: Nokia 6215i; Type: Folder; Serial: #1
Program Name: HAC H Device

Communication System: PCS1900; Frequency: 1851.25 MHz; Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³

Phantom section: H Device Section

DASY4 Configuration:

- Probe: H3DV6 - SN6101; ; Calibrated: 2005-07-20

- Sensor-Surface: (Fix Surface)

- Electronics: DAE4 Sn614; Calibrated: 2005-04-21

- Phantom: HAC Test Arch; Type: SD HAC P01 BA

H Scan 10mm above Device Reference/Hearing Aid Compatibility Test (101x101x1):

Measurement grid: dx=5mm dy=5mm

Maximum value of peak Total field = 0.051 A/m

Probe Modulation Factor = 0.980

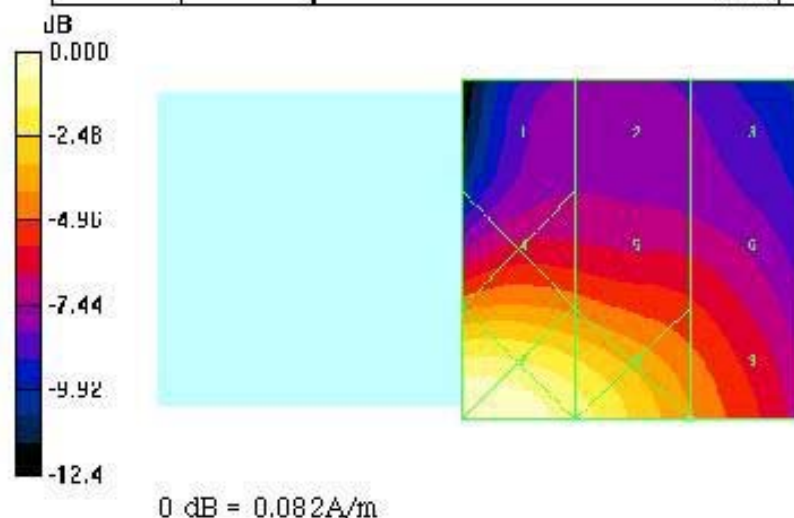
Reference Value = 0.044 A/m; Power Drift = 0.058 dB

Hearing Aid Hear-Field Category: M4 (AWF 0 dB)

Peak H-field in A/m

Grid 1	Grid 2	Grid 3
0.035	0.035	0.034
Grid 4	Grid 5	Grid 6
0.052	0.049	0.043
Grid 7	Grid 8	Grid 9
0.082	0.071	0.051

Category	AWF (dB)	Limits for E-Field Emissions (V/m)	Limits for H-Field Emissions (A/m)
M1	0	199.5 - 354.8	0.6 - 1.07
	-5	149.6 - 266.1	0.45 - 0.8
M2	0	112.2 - 199.5	0.34 - 0.6
	-5	84.1 - 149.6	0.25 - 0.45
M3	0	63.1 - 112.2	0.19 - 0.34
	-5	47.3 - 84.1	0.15 - 0.25
M4	0	<63.1	<0.19
	-5	<47.3	<0.15



Test Laboratory: HCT

DUT: Nokia 6215i; Type: Folder; Serial: #1

Program Name: HAC H Device

Communication System: PCS1900; Frequency: 1851.25 MHz; Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³

Phantom section: H Device Section

DASY4 Configuration:

- Probe: H3DV6 - SN6101; ; Calibrated: 2005-07-20

- Sensor-Surface: (Fix Surface)

- Electronics: DAE4 Sn614; Calibrated: 2005-04-21

- Phantom: HAC Test Arch; Type: SD HAC P01 BA

H Scan 10mm above Device Reference/Hearing Aid Compatibility Test (101x101x1):

Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.078 A/m

Probe Modulation Factor = 0.960

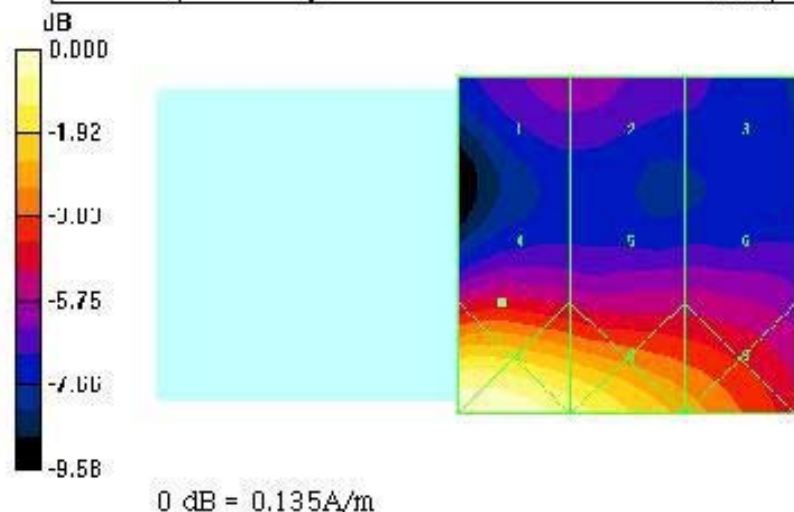
Reference Value = 0.069 A/m; Power Drift = -0.185 dB

Hearing Aid Hear-Field Category: M4 (AWF 0 dB)

Peak H-field in A/m

Grid 1	Grid 2	Grid 3
0.067	0.067	0.062
Grid 4	Grid 5	Grid 6
0.078	0.074	0.073
Grid 7	Grid 8	Grid 9
0.135	0.122	0.098

Category	AWF (dB)	Limits for E-Field Emissions (V/m)	Limits for H-Field Emissions (A/m)
M1	0	199.5 - 354.8	0.6 - 1.07
	-5	149.6 - 266.1	0.45 - 0.8
M2	0	112.2 - 199.5	0.34 - 0.6
	-5	84.1 - 149.6	0.25 - 0.45
M3	0	63.1 - 112.2	0.19 - 0.34
	-5	47.3 - 84.1	0.15 - 0.25
M4	0	<63.1	<0.19
	-5	<47.3	<0.15



Test Laboratory: HCT

DUT: Nokia 6215i; Type: Folder; Serial: #1
Program Name: HAC H Device

Communication System: PCS1900; Frequency: 1880 MHz; Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³

Phantom section: H Device Section

DASY4 Configuration:

- Probe: H3DV6 - SN6101; ; Calibrated: 2005-07-20

- Sensor-Surface: (Fix Surface)

- Electronics: DAE4 Sn614; Calibrated: 2005-04-21

- Phantom: HAC Test Arch; Type: SD HAC P01 BA

H Scan 10mm above Device Reference/Hearing Aid Compatibility Test (101x101x1):

Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.047 A/m

Probe Modulation Factor = 0.960

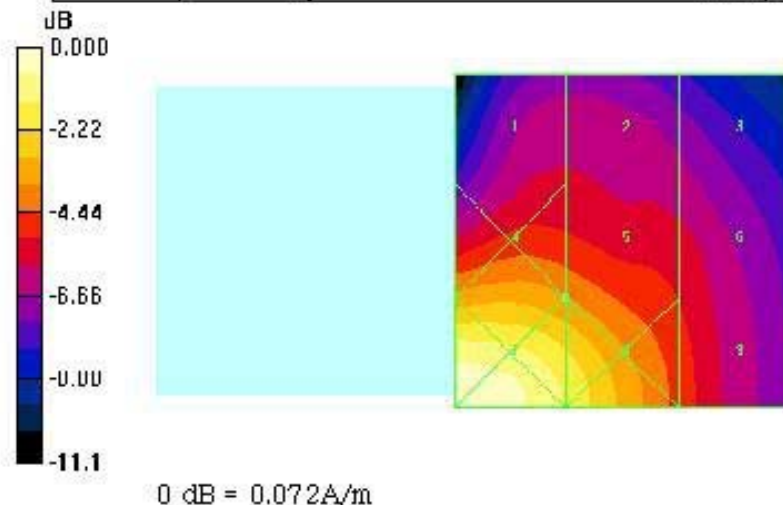
Reference Value = 0.042 A/m; Power Drift= 0.151 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak H-field in A/m

Grid 1	Grid 2	Grid 3
0.037	0.037	0.035
Grid 4	Grid 5	Grid 6
0.050	0.047	0.040
Grid 7	Grid 8	Grid 9
0.072	0.060	0.042

Category	AWF (dB)	Limits for E-Field Emissions (V/m)	Limits for H-Field Emissions (A/m)
M1	0	199.5 - 354.8	0.6 - 1.07
	-5	149.6 - 266.1	0.45 - 0.8
M2	0	112.2 - 199.5	0.34 - 0.6
	-5	84.1 - 149.6	0.25 - 0.45
M3	0	63.1 - 112.2	0.19 - 0.34
	-5	47.3 - 84.1	0.15 - 0.25
M4	0	<63.1	<0.19
	-5	<47.3	<0.15



Test Laboratory: HCT

DUT: Nokia 6215i; Type: Folder; Serial: #1
Program Name: HAC H Device

Communication System: PCS1900; Frequency: 1880 MHz; Duty Cycle: 1:1

Medium parameters used: $\sigma = 0 \text{ mho/m}$, $\epsilon_r = 1$; $\rho = 1 \text{ kg/m}^3$

Phantom section: H Device Section

DASY4 Configuration:

- Probe: H3DV6 - SN6101; ; Calibrated: 2005-07-20
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn614; Calibrated: 2005-04-21
- Phantom: HAC Test Arch; Type: SD HAC P01 BA

H Scan 10mm above Device Reference/Hearing Aid Compatibility Test (101x101x1):

Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.075 A/m

Probe Modulation Factor = 0.980

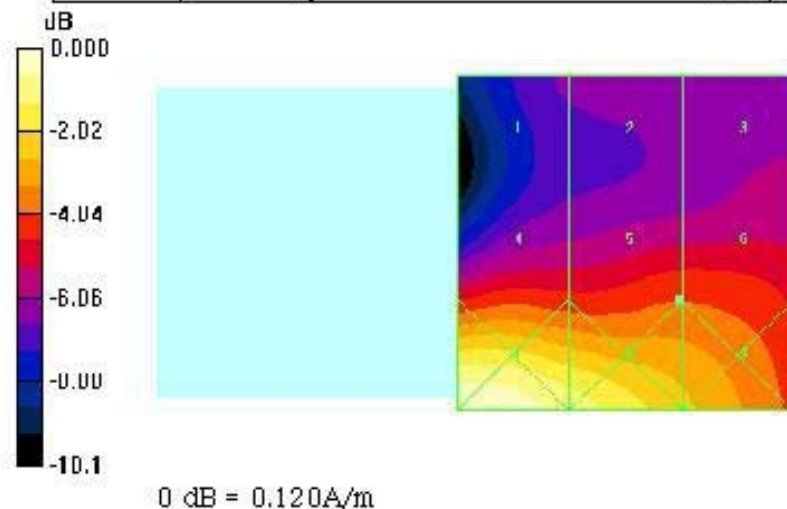
Reference Value = 0.088 A/m; Power Drift= 0.018 dB

Hearing Aid Hear-Field Category: M4 (AWF 0 dB)

Peak H-field in A/m

Grid 1	Grid 2	Grid 3
0.057	0.059	0.061
Grid 4	Grid 5	Grid 6
0.074	0.075	0.075
Grid 7	Grid 8	Grid 9
0.120	0.108	0.090

Category	AWF (dB)	Limits for E-Field Emissions (V/m)	Limits for H-Field Emissions (A/m)
M1	0	199.5 - 354.8	0.6 - 1.07
	-5	149.6 - 266.1	0.45 - 0.8
M2	0	112.2 - 199.5	0.34 - 0.6
	-5	84.1 - 149.6	0.25 - 0.45
M3	0	63.1 - 112.2	0.19 - 0.34
	-5	47.3 - 84.1	0.15 - 0.25
M4	0	<63.1	<0.19
	-5	<47.3	<0.15



Test Laboratory: HCT

DUT: Nokia 6215i; Type: Folder; Serial: #1
Program Name: HAC H Device

Communication System: PCS1900; Frequency: 1908.75 MHz; Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³

Phantom section: H Device Section

DASY4 Configuration:

- Probe: H3DV6 - SN6101;; Calibrated: 2005-07-20

- Sensor-Surface: (Fix Surface)

- Electronics: DAE4 Sn614; Calibrated: 2005-04-21

- Phantom: HAC Test Arch; Type: SD HAC P01 BA

H Scan 10mm above Device Reference/Hearing Aid Compatibility Test (101x101x1):

Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.041 A/m

Probe Modulation Factor = 0.960

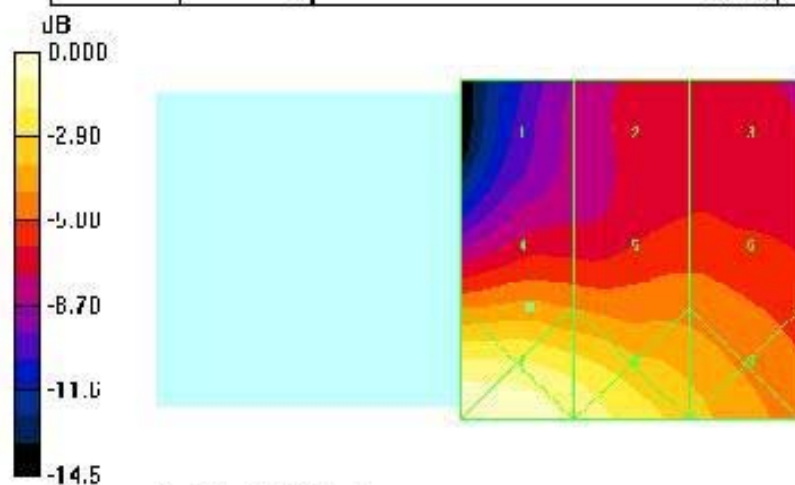
Reference Value = 0.082 A/m; Power Drift = 0.001 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak H-field in A/m

Grid 1	Grid 2	Grid 3
0.026	0.031	0.031
Grid 4	Grid 5	Grid 6
0.041	0.039	0.038
Grid 7	Grid 8	Grid 9
0.068	0.059	0.046

Category	AWF (dB)	Limits for E-Field Emissions (V/m)	Limits for H-Field Emissions (A/m)
M1	0	199.5 - 354.8	0.6 - 1.07
	-5	149.6 - 266.1	0.45 - 0.8
M2	0	112.2 - 199.5	0.34 - 0.6
	-5	84.1 - 149.6	0.25 - 0.45
M3	0	63.1 - 112.2	0.19 - 0.34
	-5	47.3 - 84.1	0.15 - 0.25
M4	0	<63.1	<0.19
	-5	<47.3	<0.15



Test Laboratory: HCT

DUT: Nokia 6215i; Type: Folder; Serial: #1
Program Name: HAC H Device

Communication System: PCS1900; Frequency: 1908.75 MHz; Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³

Phantom section: H Device Section

DASY4 Configuration:

- Probe: H3DV6 - SN6101; ; Calibrated: 2005-07-20

- Sensor-Surface: (Fix Surface)

- Electronics: DAE4 Sn614; Calibrated: 2005-04-21

- Phantom: HAC Test Arch; Type: SD HAC P01 BA

H Scan 10mm above Device Reference/Hearing Aid Compatibility Test (101x101x1):

Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.067 A/m

Probe Modulation Factor = 0.960

Reference Value = 0.052 A/m; Power Drift = -0.111 dB

Hearing Aid Hear-Field Category: M4 (AWF 0 dB)

Peak H-field in A/m

Grid 1	Grid 2	Grid 3
0.049	0.055	0.056
Grid 4	Grid 5	Grid 6
0.055	0.063	0.067
Grid 7	Grid 8	Grid 9
0.114	0.100	0.085

Category	AWF (dB)	Limits for E-Field Emissions (V/m)	Limits for H-Field Emissions (A/m)
M1	0	199.5 - 354.8	0.6 - 1.07
	-5	149.6 - 266.1	0.45 - 0.8
M2	0	112.2 - 199.5	0.34 - 0.6
	-5	84.1 - 149.6	0.25 - 0.45
M3	0	63.1 - 112.2	0.19 - 0.34
	-5	47.3 - 84.1	0.15 - 0.25
M4	0	<63.1	<0.19
	-5	<47.3	<0.15

